## Search Notes



App	lication/Control No.	Applicant(s)/Patent Under Reexamination
1059	0791	HEUER ET AL.
Exa	niner	Art Unit
Quo	c A Tran	2176

## SEARCHED ubclass Da

Class	Subclass	Date	Examiner
715	234	8/28/2008	QT
715	235-250	8/28/2008	QT
Updated	Updated	2/10/2009	QT
Updated	Updated	5/21/2009	QT

SEARCH NOTES			
Search Notes	Date	Examiner	
NPL Search (ACM Digital Library)	8/28/2008	QT	
EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO, DERWENT & IBM_TDB)	8/28/2008	QT	
Inventors Searched Conducted- Considered Double Patent Rejection	8/28/2008	QT	
Text Search Class 715/234-250	8/28/2008	QT	
Updated	2/10/2009	QT	
Updated	5/21/2009	QT	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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